## <u>Exploring Emergent Electromagnetic Properties through Multi-dimensional Electron</u> <u>Microscopy</u>

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The emergent electromagnetic properties in strongly correlated electron systems arise from exotic electron spin and polar textures [1,2]. To realize spin and polar textures such as three-dimensional (3D) skyrmion strings [3], monopoles and antimonopoles [4], and even electron-dipolar vortex textures [2] in these materials, vector-field electron tomography (3D electron microscopy) [5] and 4D scanning transmission electron microscopy (4D-STEM) are essential [2]. Here, we demonstrate cryogenic scalar/vector-field electron tomography, enabling 3D mapping of spin textures at nanometer resolution and at temperatures well below room temperature [6]. This method allows direct visualization of 3D topological spin textures, including magnetic hopfions [7]. Furthermore, 4D-STEM combined with charge distribution analysis has been applied to twisted bilayer chalcogenides, revealing twist-angle-dependent in-plane polar structures in 2D systems. Together, these advances multi-dimensional electron microscopy as a powerful platform for directly probing real-space topology and elucidating the associated emergent electrical responses.

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